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<a href="#">60126360</a>	Not Issued	159	03/26/1999	EMBEDDED TRELLIS CODED QUANTIZATION	BRUNK, HUGH L.

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Ming Sun Fu; Au, O.C.;

Circuits and Systems, 2004. ISCAS '04. Proceedings of the 2004 International Symposium on Volume 2, 23-26 May 2004 Page(s):II - 21-4 Vol.2

[AbstractPlus](#) | Full Text: [PDF](#)(588 KB) IEEE CNF**2. Joint halftoning and watermarking**

Kacker, D.; Allebach, J.P.;

Image Processing, 2000. Proceedings. 2000 International Conference on Volume 2, 10-13 Sept. 2000 Page(s):69 - 72 vol.2

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